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MOSFET – Power, Single N-Channel 40 V, 7.3 mΩ, 52 A

Features

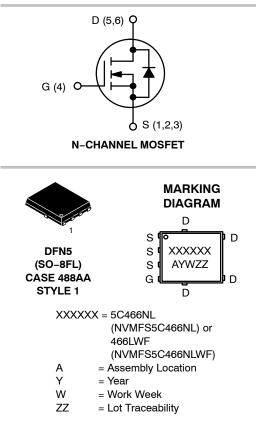
- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS5C466NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant



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V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
40.14	7.3 m Ω @ 10 V	52 A
40 V	12 mΩ @ 4.5 V	52 A



MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	40	V
Gate-to-Source Voltage	e		V _{GS}	±20	V
Continuous Drain		$T_{C} = 25^{\circ}C$	I _D	52	А
Current R _{θJC} (Notes 1, 3)	Steady	T _C = 100°C		37	
Power Dissipation	State	$T_{C} = 25^{\circ}C$	PD	37	W
R _{θJC} (Note 1)		$T_{C} = 100^{\circ}C$		19	
Continuous Drain		$T_A = 25^{\circ}C$	I _D	16	А
Current R _{θJA} (Notes 1, 2, 3)	Steady	T _A = 100°C		11	
Power Dissipation	State	T _A = 25°C	PD	3.5	W
$R_{\theta JA}$ (Notes 1 & 2)		T _A = 100°C		1.75	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	238.6	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to + 175	°C
Source Current (Body Diode)			۱ _S	31.25	А
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 2.93 A)			E _{AS}	65	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	4.0	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	43	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 5 of this data sheet.

Downloaded from Arrow.com.

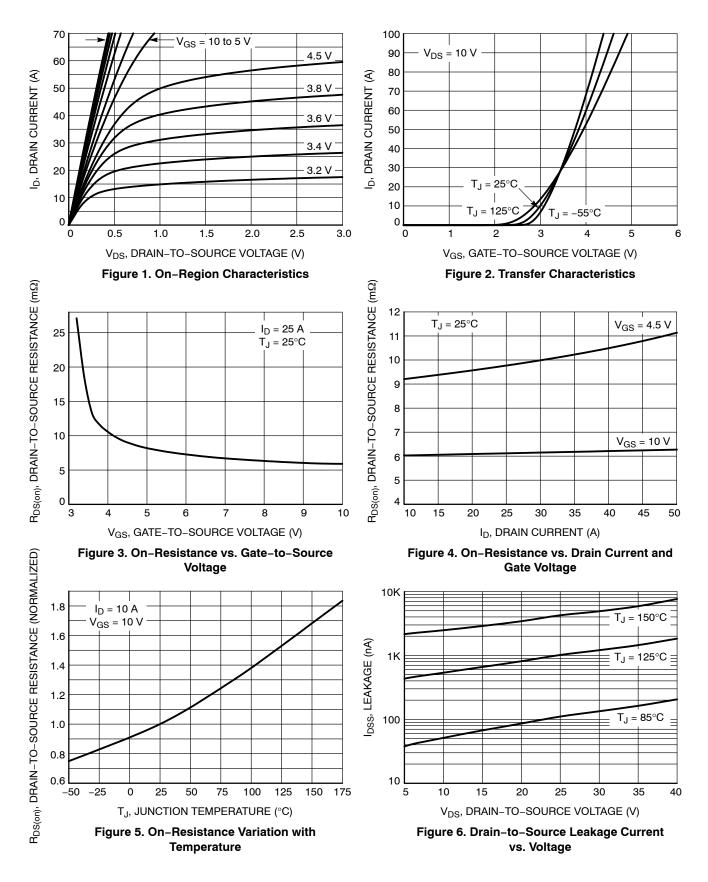
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

$ \begin{array}{ c c c c c c c } \hline \mbox{trans} t$	Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	OFF CHARACTERISTICS								
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		40			V	
$\begin{tabular}{ c c c c c c } \hline \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$						25		mV/°C	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	T _J = 25 °C			10		
$\begin{array}{ c c c c c c } \hline 0 & C & C & C & C & C & C & C & C & C &$			V _{DS} = 40 V	T _J = 125°C			250	μΑ	
Gate Threshold Voltage VGS(TH) VGS = VDS, ID = 30 μ A 1.2 2.2 V Threshold Temperature Coefficient VGS(TH)/TJ 4.9 mV/ Drain-to-Source On Resistance RDS(on) VGS = 4.5 V ID = 10 A 8.7 12 mS/ Drain-to-Source On Resistance RDS(on) VGS = 10 V ID = 10 A 6.1 7.3 mS/ Forward Transconductance GFS VDS = 15 V, ID = 10 A 33 S S CHARGES, CAPACITANCES & GATE RESISTANCE Input Capacitance CGS VGS = 0 V, f = 1 MHz, VDS = 25 V 360 pF Reverse Transfer Capacitance CRS VGS = 10 V, VDS = 32 V; ID = 10 A 7 nC Total Gate Charge QG(TOT) VGS = 4.5 V, VDS = 32 V; ID = 10 A 7 nC Total Gate Charge QG(GTOT) VGS = 10 V, VDS = 32 V; ID = 10 A 16 nC Threshold Gate Charge QGG VGS 10 V, VDS = 32 V; ID = 10 A 18 1 Gate-to-Drain Charge QGS VGS 10 V, VDS = 32 V; ID = 10 A 18 1	Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	_s = 20 V			100	nA	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	ON CHARACTERISTICS (Note 4)								
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D	= 30 μA	1.2		2.2	V	
$ \begin{array}{c c c c c c c c c c c c c c c } \hline Part & Part $	Threshold Temperature Coefficient					-4.9		mV/°C	
$ \begin{array}{ c c c c c } \hline Forward Transconductance & GFS & V_{DS} = 15 \ V, \ I_{D} = 10 \ A & 33 & S \\ \hline \mbox{CHARGES, CAPACITANCES & GATE RESISTANCE} & & & & & & & & & & & & & & & & & & &$	Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 4.5 V	I _D = 10 A		9.7	12	mΩ	
$ \begin{array}{c c c c c c c c c } \hline Forward Transconductance & g_{FS} & V_{DS} = 15 \ V, \ I_D = 10 \ A & 33 & S \\ \hline \mbox{CHARGES, CAPACITANCES & GATE RESISTANCE} \\ \hline \mbox{Input Capacitance} & C_{ISS} & V_{GS} = 0 \ V, \ f = 1 \ MHz, \ V_{DS} = 25 \ V & 360 & PF \\ \hline \mbox{Output Capacitance} & C_{RSS} & V_{GS} = 0 \ V, \ f = 1 \ MHz, \ V_{DS} = 25 \ V & 360 & PF \\ \hline \mbox{Teverse Transfer Capacitance} & C_{RSS} & 15 & 16 & 16 & PF \\ \hline \mbox{Total Gate Charge} & Q_{G(TOT)} & V_{GS} = 4.5 \ V, \ V_{DS} = 32 \ V, \ I_D = 10 \ A & 7 & nc \\ \hline \mbox{Total Gate Charge} & Q_{G} & V_{GS} = 10 \ V, \ V_{DS} = 32 \ V, \ I_D = 10 \ A & 16 & nc \\ \hline \mbox{Threshold Gate Charge} & Q_{GG} & V_{GP} & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 & 1.8 $	Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		6.1	7.3	mΩ	
$\begin{array}{ c c c c c c } \hline \mbox{Input Capacitance} & C_{ISS} & V_{GS} = 0 \ V, \ f = 1 \ MHz, \ V_{DS} = 25 \ V & 360 & P \ P \ P \ P \ P \ P \ P \ P \ P \ P$	Forward Transconductance		V _{DS} =15 V, I _D	= 10 A		33		S	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	CHARGES, CAPACITANCES & GATE RE	SISTANCE							
$\begin{array}{ c c c c c c c } \hline Reverse Transfer Capacitance & C_{RSS} & 15 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & 0 & $	Input Capacitance	C _{ISS}				860			
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Output Capacitance	C _{OSS}				360		pF	
$ \begin{array}{c c c c c c c } \hline \mbox{Total Gate Charge} & Q_G(TOT) & V_{GS} = 10 \ V, \ V_{DS} = 32 \ V; \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $	Reverse Transfer Capacitance	C _{RSS}				15			
$ \begin{array}{ c c c c c c c } \hline Threshold Gate Charge & $Q_{G(TH)}$ \\ \hline Gate-to-Source Charge & Q_{GS} \\ \hline Gate-to-Drain Charge & Q_{GD} \\ \hline & Q_{GD} \\ \hline & $Q_{SS} = 10 \ V, \ V_{DS} = 32 \ V; \ I_D = 10 \ A \\ \hline & $2.5 \\ \hline & $3.3 \\ \hline & $2.5 \\ \hline & $3.4 \\ \hline & $3.4 \\ \hline & $2.5 \\ \hline & $3.4 \\ \hline$	Total Gate Charge	Q _{G(TOT)}				7		nC	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} = 32 V; I_{D} = 10 A			16		nC	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Threshold Gate Charge	Q _{G(TH)}	-			1.8			
$ \begin{array}{c c c c c c c c c } \hline Gate - to - Drain Charge & Q_{GD} & & & & & & & & & & & & & & & & & & &$	Gate-to-Source Charge	Q _{GS}				3.3		nC V	
SWITCHING CHARACTERISTICS (Note 5) Turn-On Delay Time $t_{d(ON)}$ Rise Time t_r Turn-Off Delay Time $t_{d(OFF)}$ Fall Time t_f DRAIN-SOURCE DIODE CHARACTERISTICS V_{GS} = 0 V, $l_S = 10 \text{ A}$, $R_G = 1 \Omega$ $T_J = 25^{\circ}C$ 0.84 1.2 V Forward Diode Voltage VSD $V_{GS} = 0 \text{ V}, l_S = 10 \text{ A}$ $T_J = 25^{\circ}C$ 0.84 1.2 V Reverse Recovery Time t_RR $V_{GS} = 0 \text{ V}, dl_S/dt = 100 \text{ A/µs}, l_S = 10 \text{ A}$ 111 112 112	Gate-to-Drain Charge	Q _{GD}				2.5			
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	Plateau Voltage	V _{GP}				3.4			
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	SWITCHING CHARACTERISTICS (Note 5	5)					1	1	
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Turn–On Delay Time	t _{d(ON)}				8			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Rise Time		V_{GS} = 10 V, V_{DS} = 32 V, I_{D} = 10 A, R_{G} = 1 Ω			24		ns	
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Turn-Off Delay Time	t _{d(OFF)}				29			
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Fall Time					6			
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	DRAIN-SOURCE DIODE CHARACTERIS	TICS							
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Forward Diode Voltage	V _{SD}	v _{GS} = 0 v,			0.84	1.2		
$\begin{array}{c c c c c c c c c c c c c c c c c c c $						0.71		V	
Discharge Time t_b $I_S = 10 \text{ A}$ 12	Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/µs,			24			
Discharge Time t _b I _S = 10 A 12	Charge Time	t _a				11		ns	
Reverse Recovery Charge Q _{RR} 11 nC	Discharge Time					12		1	
	Reverse Recovery Charge	Q _{RR}				11		nC	

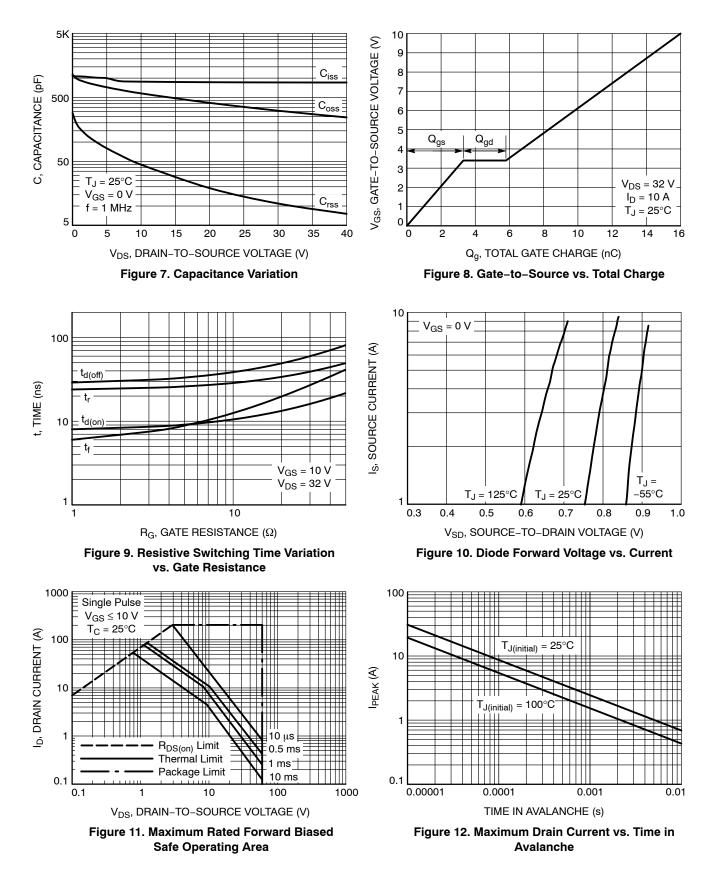
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

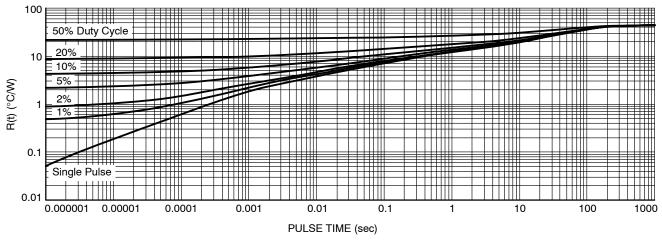


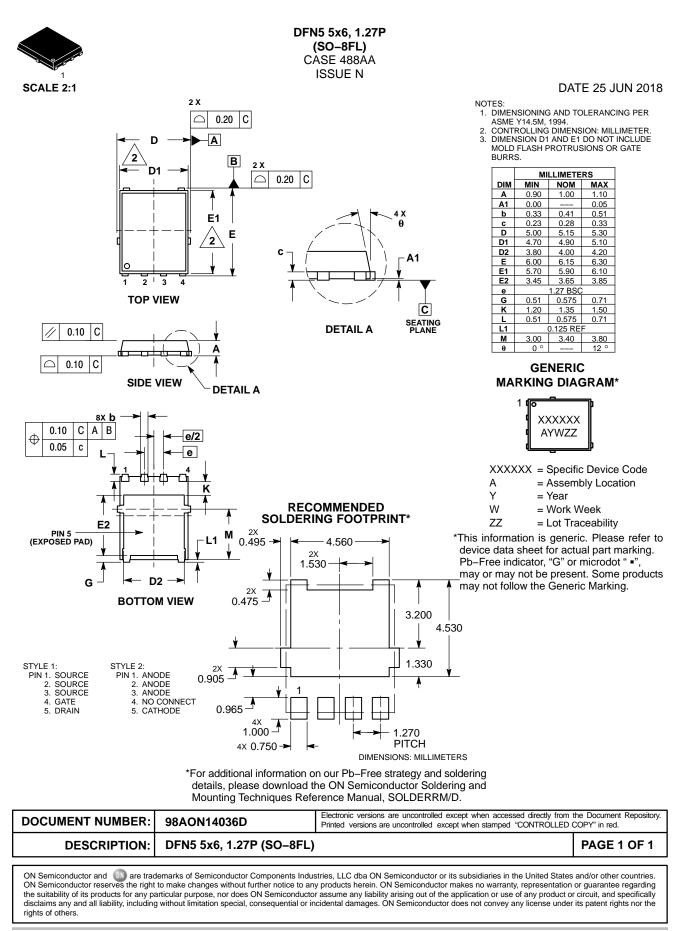
Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS5C466NLT1G	5C466L	DFN5 (Pb-Free)	1500 / Tape & Reel
NVMFS5C466NLWFT1G	466LWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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